

Search Notes

Application/Control No.

10/765,936

Examiner

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Applicant(s)/Patent under
Reexamination

BARKAN, YUVAL

Art Unit

2683

SEARCHED

Class	Subclass	Date	Examiner
455	449	2/14/2006	CH.
455	444	2/14/2006	CH.
455	456.6	2/14/2006	CH.
455	422.1	2/14/2006	CH.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Class/Subclass/Combined Text	2/9/2006	CH.
Citations/IDS	2/9/2006	CH.